

Notice of References Cited	Application/Control No. 10/627,871		Applicant(s)/Patent Under Reexamination PARIDA ET AL.	
	Examiner LINH V. NGUYEN		Art Unit 2819	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0139187	06-2006	Helfman et al.	341/051
*	B	US-2006/0059187	03-2006	Brown, Richard H.	707/102
*	C	US-2003/0090740	05-2003	Trelewicz, Jennifer Q.	358/426.13
*	D	US-2003/0090702	05-2003	Trelewicz, Jennifer Q.	358/1.15
*	E	US-6,416,410	07-2002	Abou-Samra et al.	463/31
*	F	US-5,845,238	12-1998	Fredenburg, Timothy	704/1
*	G	US-3,656,178	04-1972	De Maine et al.	341/87
*	H	US-6,420,980	07-2002	Ejima, Naoki	341/65
*	I	US-5,703,907	12-1997	James, David C.	375/240
*	J	US-7,280,057	10-2007	Delfs et al.	341/87
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.